

**Notice of References Cited**

Application/Control No.

09/461,756

Applicant(s)/Patent Under Reexam

Kano

Examiner

B. William Baumeister

Art Unit

2815

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**U.S. PATENT DOCUMENTS**

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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	B	5,391,893	2/1995	Yamazaki	257	52
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**FOREIGN PATENT DOCUMENTS**

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
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**NON-PATENT DOCUMENTS**

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
	U	Sze, "Physics of Semiconductor Devices," 1981, John Wiley & Sons, Inc., pp. 743-760.
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<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(e).<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.